

<p>Search Notes</p> 				<p>Application/Control No.</p> <p>09/687,528</p> <p>Examiner</p> <p>Shin-Lin Chen</p>		<p>Applicant(s)/Patent under Reexamination</p> <p>STERN ET AL.</p> <p>Art Unit</p> <p>1632</p>	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
Class	Subclass	Date	Examiner			DATE	EXMR
Updated		5/16/2005	<i>SLC</i>			5/16/2005	<i>SLC</i>
INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				